Search Notes

Application/Control No.	Applicant(s)/Patent (Applicant(s)/Patent under Reexamination	
10/042,231	NAKANO, MASAKI	NAKANO, MASAKI	
Examiner	Art Unit		

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2676

SEARCHED				
Class	Subclass	Date	Examiner	
348	588	1/24/2006	AMR	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB)	1/24/2006	AMR		
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